Applicant(s)/Patent Under Application/Control No. Reexamination 10/742,919 LEE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Tai Duong 2871 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 349/106 US-2003/0081155 05-2003 Α Moon et al. US-В С US-D US-Ε US-F US-G US-Н US-US-US-J US-Κ US-L М US-**FOREIGN PATENT DOCUMENTS Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 P Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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